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. . eescale Semiconductor

Technical Data

RF Power Field Effect Transistors

N-Channel Enhancement-Mode Lateral MOSFETs

Designed for N-CDMA base station applications with frequencies from 1930 to 1990 MHz. Suitable for TDMA, CDMA and multicarrier amplifier applications. To be used in Class AB for PCN-PCS/cellular radio and WLL applications.

- Typical 2-Carrier N-CDMA Performance: V_{DD} = 28 Volts, I_{DQ} = 900 mA, P_{out} = 22 Watts Avg., f = 1987 MHz, IS-95 (Pilot, Sync, Paging, Traffic Codes 8 Through 13) Channel Bandwidth = 1.2288 MHz. PAR = 9.8 dB
 @ 0.01% Probability on CCDF.
 - Power Gain 16.1 dB Drain Efficiency — 28% IM3 @ 2.5 MHz Offset — -37 dBc in 1.2288 MHz Channel Bandwidth ACPR @ 885 kHz Offset — -51 dBc in 30 kHz Channel Bandwidth
- Capable of Handling 10:1 VSWR, @ 28 Vdc, 1960 MHz, 100 Watts CW Output Power

Features

- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Internally Matched for Ease of Use
- Qualified Up to a Maximum of 32 V_{DD} Operation
- Integrated ESD Protection
- Designed for Lower Memory Effects and Wide Instantaneous Bandwidth
 Applications
- RoHS Compliant
- In Tape and Reel. R3 Suffix = 250 Units per 56 mm, 13 inch Reel.

Document Number: MRF6S19100H Rev. 5, 12/2008

MRF6S19100HR3 MRF6S19100HSR3

1930-1990 MHz, 22 W AVG., 28 V 2 x N-CDMA LATERAL N-CHANNEL RF POWER MOSFETs

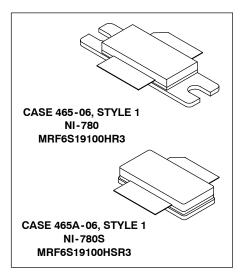


Table 1. Maximum Ratings

Rating		Value	Unit
Drain-Source Voltage	V _{DSS}	-0.5, +68	Vdc
Gate-Source Voltage	V _{GS}	-0.5, +12	Vdc
Storage Temperature Range	T _{stg}	- 65 to +150	°C
Case Operating Temperature	T _C	150	°C
Operating Junction Temperature (1,2)	TJ	225	°C

Table 2. Thermal Characteristics

Characteristic		Value ^(2,3)	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$		°C/W
Case Temperature 80°C, 100 W CW		0.44	
Case Temperature 77°C, 22 W CW		0.50	

1. Continuous use at maximum temperature will affect MTTF.

 MTTF calculator available at <u>http://www.freescale.com/rf</u>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

 Refer to AN1955, Thermal Measurement Methodology of RF Power Amplifiers. Go to <u>http://www.freescale.com/rf</u>. Select Documentation/Application Notes - AN1955.





Table 3. ESD Protection Characteristics

Test Methodology Human Body Model (per JESD22-A114)		Class 3A (Minimum)			
Charge Device Model (per JESD22-C101)		IV (Minimum)			
Fable 4. Electrical Characteristics $(T_C = 25^{\circ}C \text{ unless otherwise})$	noted)				
Characteristic	Symbol	Min	Тур	Max	Unit
Off Characteristics					
Zero Gate Voltage Drain Leakage Current (V _{DS} = 68 Vdc, V _{GS} = 0 Vdc)	I _{DSS}	—	_	10	μAdo
Zero Gate Voltage Drain Leakage Current (V _{DS} = 28 Vdc, V _{GS} = 0 Vdc)	I _{DSS}			1	μAdo
Gate - Source Leakage Current $(V_{GS} = 5 \text{ Vdc}, V_{DS} = 0 \text{ Vdc})$	I _{GSS}	_	_	1	μAdo
On Characteristics					
Gate Threshold Voltage (V_{DS} = 10 Vdc, I_D = 250 μ Adc)	V _{GS(th)}	1	2	3	Vdc
Gate Quiescent Voltage $(V_{DD} = 28 \text{ Vdc}, I_D = 900 \text{ mAdc}, \text{Measured in Functional Test})$	V _{GS(Q)}	2	2.8	4	Vdc
Drain - Source On - Voltage ($V_{GS} = 10 \text{ Vdc}, I_D = 2.2 \text{ Adc}$)	V _{DS(on)}	0.1	0.21	0.3	Vdc
Dynamic Characteristics ⁽¹⁾	· · ·				
Reverse Transfer Capacitance (V _{DS} = 28 Vdc ± 30 mV(rms)ac @ 1 MHz, V _{GS} = 0 Vdc)	C _{rss}	_	1.5	_	pF

N-CDMA, 1.2288 MHz Channel Bandwidth Carriers. ACPR measured in 30 kHz Channel Bandwidth @ ±885 kHz Offset. IM3 measured in 1.2288 MHz Channel Bandwidth @ ±2.5 MHz Offset. PAR = 9.8 dB @ 0.01% Probability on CCDF.

Power Gain	G _{ps}	15	16.1	18	dB
Drain Efficiency		26	28	—	%
Intermodulation Distortion	IМЗ	—	-37	-35	dBc
Adjacent Channel Power Ratio		—	-51	-48	dBc
Input Return Loss	IRL	—	- 15	-9	dB

1. Part is internally matched both on input and output.



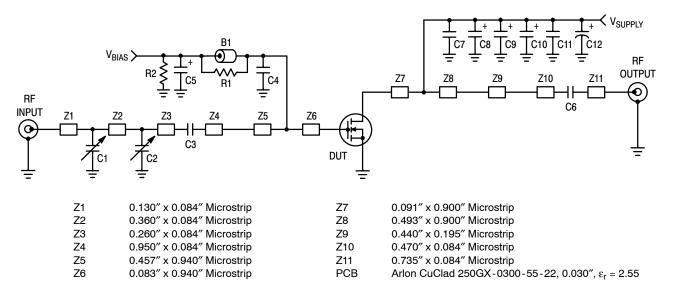
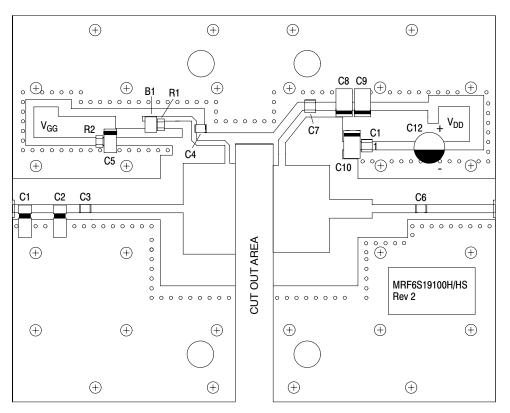


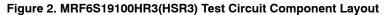
Figure 1. MRF6S19100HR3(HSR3) Test Circuit Schematic

Part	Description	Part Number	Manufacturer
B1	RF Bead	2743019447	Fair-Rite
C1, C2	0.6-4.5 pF Variable Capacitors, Gigatronics	27271SL	Johanson Dielectrics
C3	15 pF Chip Capacitor	ATC100B150CT500XT	ATC
C4, C7	5.6 pF Chip Capacitors	ATC100B5R6JT500XT	ATC
C5	1 μ F, 50 V Tantalum Chip Capacitor	T491C105K050AT	Kemet
C6	43 pF Chip Capacitor	ATC100B430CT500XT	ATC
C8, C10	22 μ F, 35 V Tantalum Chip Capacitors	T491X226K035AT	Kemet
C9	10 µF, 35 V Tantalum Chip Capacitor	T491C106K035AT	Kemet
C11	0.1 μF Chip Capacitor	C1825C14J5RAC	Kemet
C12	100 μ F, 50 V Electrolytic Capacitor	MCHT101M1HB-1017-RH	Multicomp
R1	12 Ω, 1/4 W Chip Resistor	CRCW120612R0FKEA	Vishay
R2	2 kΩ, 1/4 W Chip Resistor	CRCW12062001FKEA	Vishay





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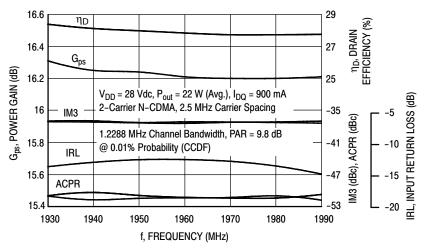


Figure 3. 2-Carrier N-CDMA Broadband Performance @ Pout = 22 Watts Avg.

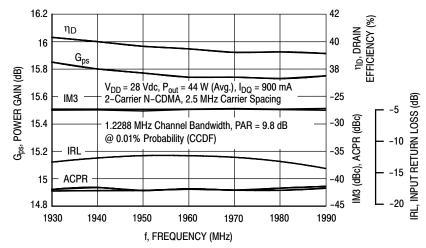
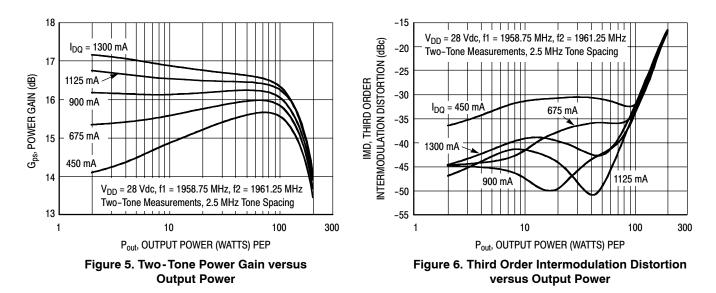
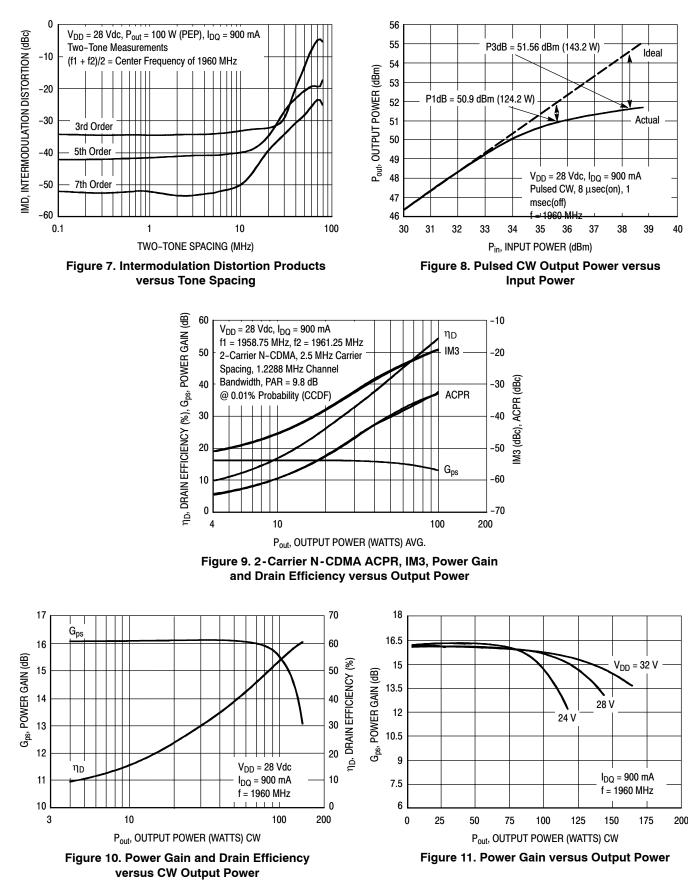


Figure 4. 2-Carrier N-CDMA Broadband Performance @ Pout = 44 Watts Avg.



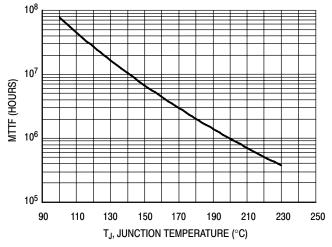
TYPICAL CHARACTERISTICS



MRF6S19100HR3 MRF6S19100HSR3



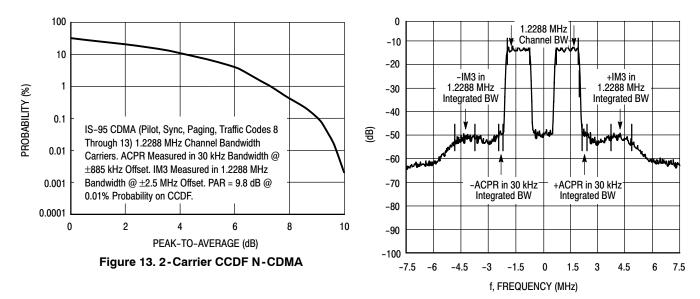
TYPICAL CHARACTERISTICS



This above graph displays calculated MTTF in hours when the device is operated at V_{DD} = 28 Vdc, P_{out} = 22 W Avg., and η_D = 28%.

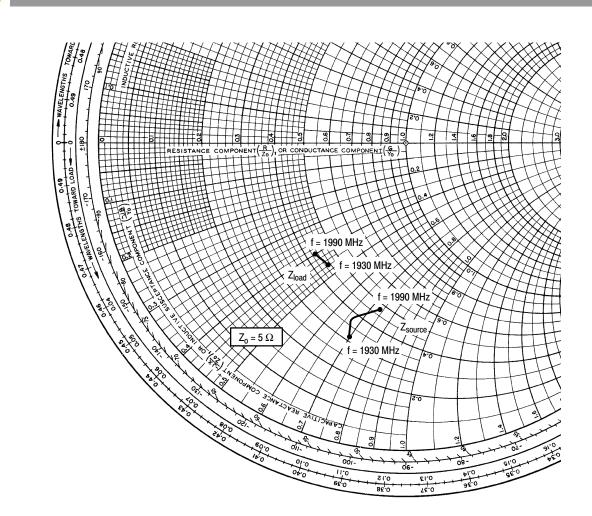
MTTF calculator available at http://www.freescale.com/rf. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.





N-CDMA TEST SIGNAL

Figure 14. 2-Carrier N-CDMA Spectrum



 V_{DD} = 28 Vdc, I_{DQ} = 900 mA, P_{out} = 22 W Avg.

f MHz	Z_{source}	Z _{load} Ω
1930	1.57 - j3.50	2.26 - j2.31
1960	1.83 - j3.29	2.22 - j2.13
1990	2.34 - j3.71	2.14 - j2.00

 Z_{source} = Test circuit impedance as measured from gate to ground.

Z_{load} = Test circuit impedance as measured from drain to ground.

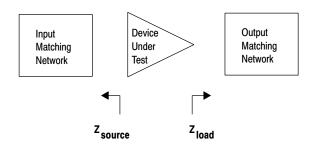
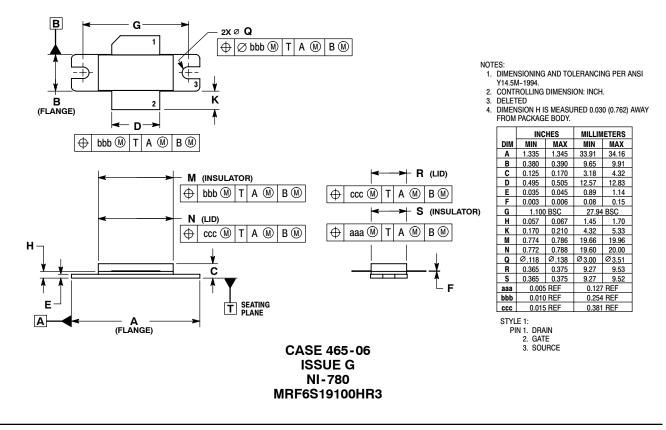
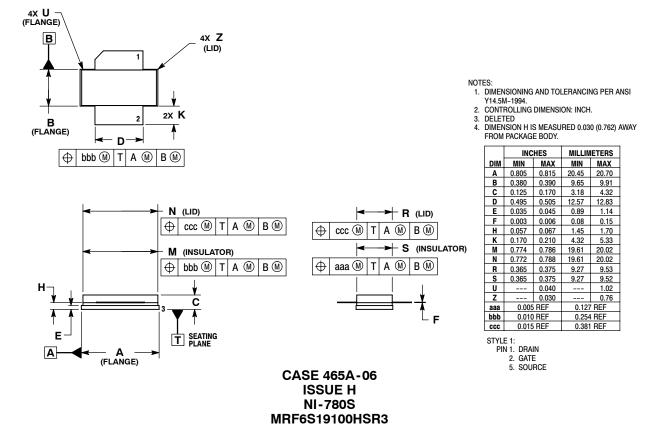


Figure 15. Series Equivalent Source and Load Impedance



PACKAGE DIMENSIONS







PRODUCT DOCUMENTATION

Refer to the following documents to aid your design process.

Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers
- **Engineering Bulletins**
- EB212: Using Data Sheet Impedances for RF LDMOS Devices

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
5	Dec. 2008	 Modified data sheet to reflect RF Test Reduction described in Product and Process Change Notification number, PCN13232, p. 1, 2
		Removed Lower Thermal Resistance and Low Gold Plating bullets from Features section as functionality is standard, p. 1
		 Removed Total Device Dissipation from Max Ratings table as data was redundant (information already provided in Thermal Characteristics table), p. 1
		 Operating Junction Temperature increased from 200°C to 225°C in Maximum Ratings table, related "Continuous use at maximum temperature will affect MTTF" footnote added, p. 1
		 Corrected V_{DS} to V_{DD} in the RF test condition voltage callout for V_{GS(Q)}, and added "Measured in Functional Test", On Characteristics table, p. 2
		Removed Forward Transconductance from On Characteristics table as it no longer provided usable information, p. 2
		• Updated PCB information to show more specific material details, Fig. 1, Test Circuit Schematic, p. 3
		 Updated Part Numbers in Table 5, Component Designations and Values, to RoHS compliant part numbers, p. 3
		 Removed lower voltage tests from Fig. 11, Power Gain versus Output Power, due to fixed tuned fixture limitations, p. 6
		 Replaced Fig. 12, MTTF versus Junction Temperature with updated graph. Removed Amps² and listed operating characteristics and location of MTTF calculator for device, p. 7
		Added Product Documentation and Revision History, p. 10

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